


<b>Search Notes</b>  	<b>Application/Control No.</b>  10518824	<b>Applicant(s)/Patent Under Reexamination</b>  BAEY ET AL.
	<b>Examiner</b>  ANDREW LAI	<b>Art Unit</b>  2616

### SEARCHED

Class	Subclass	Date	Examiner
370	318	3/11/08	AL
455	127.1	3/11/08	AL
370	318,328,141,280	6/22/08	AL
455	127.1,450,522	6/22/08	AL

### SEARCH NOTES

Search Notes	Date	Examiner
conducted text search using EAST DB	3/11/08	AL
Discussion with SPE Kwang Yao on claim interpretation and final rejection	3/10/08	AL
Text search in EAST, see Search History for details	6/22/08	AL

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner